Extension to Support Types and Operation/Function Definitions in BWDM to Generate Test Case Tool from the VDM++ Specification

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Abstract
Generating test cases from the formal specification description VDM++, which is a method for disambiguating specifications, is time-consuming and labor intensive. Therefore, our laboratory has developed BWDM, a tool that automatically generates test cases from VDM++ specifications. However, existing BWDM has problems that it only supports integer types and cannot generate test cases for operation and function definitions including recursive structure. Consequently, it has confirmed that the use of extended BWDM can reduce the test case generation time compared to manual test case generation.

Keywords: software testing, formal methods, VDM++, automatic generation, test cases

1. Introduction
Today, our lives are supported by a lot of software. As a result, software has become larger and more complex, and software bugs have a greater impact on society. One of the causes of bugs in software is the use of natural language in the upstream stage of software development. This is because natural language contains ambiguity. One method to solve this problem is to design software using formal methods. VDM is one of the most common formal methods used for this purpose, and VDM++ is a formal specification description language used in VDM for object-oriented modeling [1].

On the other hand, software design using VDM++ requires software testing. However, it is time-consuming and labor-intensive to manually generate test cases from specifications written in VDM++. In addition, manual test case generation may cause leakage in testing. Therefore, our laboratory has developed BWDM [2], [3], an automatic test case generation tool for VDM++ specifications. However, existing BWDM has the problem that it only supports integer types and cannot generate test cases for operation and function definitions with recursive structure.

Therefore, to improve the usefulness of BWDM, it is extended as follows.

- Addition of a function to generate test cases for enumerated type
- Addition of a function to generate test cases for operations/functions with recursive structure

In this paper, Chapter 2 describes the existing BWDM, Chapter 3 describes the extended BWDM, Chapter 4 shows application examples, and Chapter 5 discusses and confirms the usefulness of BWDM. Chapter 6 is the conclusion.

2. BWDM
BWDM is a tool that automatically generates test cases using the VDM++ specification as input. As examples, Fig. 1 shows the VDM++ specification and Fig. 2 shows the test cases generated from it by BWDM, respectively.

3. The Extended BWDM
This chapter describes the details of the extension of BWDM. Fig. 3 shows the structure of the extended BWDM.
3.1. Addition of a Function to Generate Test Cases for Enumerated Type

To solve the problem of the existing BWDM only supporting specific types, we extend Syntax Analyzer and Symbolic Executor. Concretely, we extend BWDM to generate test cases for enumerated type consisting of a set of unique identifiers.

In the extended Syntax Analyzer, if a type definition of an enumerated type exists in the abstract syntax tree analyzing process, the corresponding type declaration is replaced with a list consisting of the declared name and values. If the substituted list exists in the syntax tree in the Symbolic Executor, JavaAPI [4] which generates enumerated type is used to generate constraints to be registered with the SMT solver [5] used in the propositional analyzer section. This additional process can generate input data for enumerated type by symbolic execution.

3.2. Addition of a Function to Generate Test Cases for Operations/Functions with Recursive Structure

To solve the problem of existing BWDM's inability to generate test cases for operation and function definitions with recursive structure, we extend Syntax Analyzer and Test Suite Generator.

In existing BWDM, when there is an operation/function call in test suite generation, test cases cannot be generated unless the parsing of the called operation/function is completed. This is the cause that the parsing of the operation/function including recursive calls is not completed and the abstract syntax tree cannot be generated.

Therefore, when there is an operation or function that has self-recursive calls, an upper limit is set on the number of recursive calls, and the abstract parse tree analysis process is modified so that it is executed after the parse tree analysis for all definitions is completed. This allows the test data generation to be performed after the parsing of the VDM++ specification given as input is completed. Additionally, a function is added that terminates the process if self-recursive calls are performed more than a limited number of times when

```
Class calendar
functions
judgeLeapYear: nat -> seq of char
judgeLeapYear(year) ==
  if(year mod 4 = 0 and ((year mod 100 = 0) =>
    (year mod 400 = 0))) then
    "Leap Year"
  else "Normal Year"
end calendar
```

Fig. 1 Example of VDM++ specification

4. Application Examples

This chapter shows application examples to confirm that the extended BWDM works correctly.

4.1. Confirmation that Test Cases can be Generated for Enumerated Type

```
Function Name : judgeLeapYear
Argument Type : current_year : nat
Return Type : seq of (char)
Number of Test Cases : 17 cases(BVA:13 /SE:4)
```

```
Boundary Values for Each Argument
current_year : 4294967295 4294967294 0 -1 3 4
```

```
Test Cases for Boundary Value Analysis
No.1 : 4294967295  -> Undefined Action
No.2 : 4294967294  -> "Normal year"
No.3 : 0   -> "Leap year"
No.4 : -1  -> Undefined Action
No.5 : 3   -> "Normal year"
No.6 : 4   -> "Leap year"
No.7 : 5   -> "Normal year"
No.8 : 99  -> "Normal year"
No.9 : 100 -> "Normal year"
No.10 : 101 -> "Normal year"
No.11 : 399 -> "Normal year"
No.12 : 400 -> "Leap year"
No.13 : 401 -> "Normal year"
```

Fig. 2 Output when Fig.1 is applied to the BWDM recursively generating output data in the output data generation section in Test Suite Generator.

Fig. 4 shows the VDM++ specification using enumerated type used for verification, and Fig.5 shows the results of applying it to the extended BWDM, respectively.

From Fig. 4, it can see that in the “judgeLightColor” function, "public TrafficLight = <BLUE><YELLOW><RED>;", is defined as the type. As output, Fig.5 shows that test cases can be generated for the definition using the enumerated type.

4.2. Confirmation that Test Cases can be Generated for Definitions with Recursive Structure

```
Fig. 6 shows the VDM++ specification using a definition with recursive structure used for verification, and Fig 7
```

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shows the results of applying it to the extended BWDM, respectively.

From Fig. 6, it can see that in the "calcSum" function is defined with recursive structure. As output, Fig. 7 shows that test cases can be generated for definition with recursive structure.

5. Discussion
5.1. Evaluation of Test Cases Generation for Definitions using Enum Type

As shown in Section 4.1, we have confirmed that the extended BWDM can generate test cases from definitions using enumerated type in the VDM++ specification of Fig. 4. Therefore, it can be said that this extension enables BWDM to generate test cases from definitions using enumerated type. Thus, the usefulness of BWDM has been improved.

5.2. Evaluation of Test Case Generation for Definitions with Recursive Structure

As shown in Section 4.2, we have confirmed that the extended BWDM can generate test cases from definition with recursive structure in the VDM++ specification of Fig. 6. Therefore, it can be said that this extension enables BWDM to generate test cases from definitions with recursive structure. Thus, the usefulness of BWDM has been improved.

5.3. Comparison with Manual Test Case Generation Time

Using the extended BWDM, we evaluate the test case generation time for the VDM++ specifications which include definitions with enumerated type and recursive structure, by comparing it to the human case. Two VDM++ specifications, Fig. 4 and Fig. 6, are used in the
Fig. 6 VDM++ specification with recursive structure

```plaintext
Class calcSum

factorial : nat == nat
factorial : nat == nat
factorial : nat == nat

if value = 0 then 0
else value + factorial (value - 1)

end calcSum
```

Fig. 6 VDM++ specification with recursive structure

Function Name : calcSum
Argument Type : value: nat
Return Type : nat

Boundary Values for Each Argument
value: 4294967295 4294967294 0 -1

Test Cases of Boundary Values
No.1 : 4294967295 → Undefined Action
No.2 : 429467294 → Undefined Action
No.3 : 0 → 0
No.4 : 1 → Undefined Action

Fig. 7 Output when Fig.6 is applied to the extended BWDM

experiment. The manual verification is performed by a total of five people, two graduate students and three fourth-year undergraduates in our laboratory. We measure the time required to generate sufficient test cases from the VDM++ specification, which are no leakage. The time measurement is terminated when the subjects have generated the correct test cases, and when the manually test cases includes any incorrect test cases, the mistakes are pointed out. The comparison results are shown in Table 1.

Table 1 shows that about 14 minutes are saved when using the extended BWDM to generate test cases compared to manual test case creation. In addition, human error has been observed in the manual test case creation.

In this research, we have confirmed that an extended BWDM that adds a test case generation function for definitions using enumerated type and recursive structure can reduce the time and human errors required for test case generation. Therefore, it can be said that the usefulness of BWDM has been improved.

<table>
<thead>
<tr>
<th>Test Case Generation Time</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Average of 10 subjects</strong></td>
</tr>
<tr>
<td><strong>BWDM</strong></td>
</tr>
<tr>
<td><strong>14m29s</strong></td>
</tr>
<tr>
<td><strong>2.6s</strong></td>
</tr>
</tbody>
</table>

Table 1 Comparison of test case generation time

6. Conclusion

In order to improve the usefulness of BWDM, an automatic test case generation tool for the VDM++ specification, two extensions have been made to the existing BWDM to solve the problems that only supports integer types and that it cannot generate test cases for operation and function definitions with recursive structure.

The application examples of the extended BWDM are shown, and the test case generation function for definitions using enumerated type and definitions with recursive structure for expanding the range of supported types is confirmed. We have confirmed that the extended BWDM can reduce test case generation time by about 14 minutes compared to manually generating test cases from VDM++ specifications. In addition, we have confirmed that the extended BWDM can eliminate human errors. Therefore, it can be said that the usefulness of BWDM has been improved by the extensions in this paper.

The future issues are the following.

- Support for types other than integer and enumerated type
- Test case generation for input values with more recursive calls
- Test case generation for mutually recursive functions

References

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